## National Semiconductor

## Programmable Array Logic (PAL®) 24-Pin Small PAL Family

#### **General Description**

The 24-pin Small PAL family contains six popular PAL architectures. The devices in the Small PAL family draw only 100 mA maximum supply current as compared to 210 mA in the 24-pin Medium PAL devices. These devices offer speeds as fast as 25 ns maximum propagation delay. National Semiconductor's Schottky TTL process with titanium tungsten fusible links provides high-speed user-programmable replacements for conventional SSI/MSI logic with significant chip-count reduction.

Programmable logic devices provide convenient solutions for a wide variety of application-specific functions, including random logic, custom decoders, state machines, etc. By programming fusible links to configure AND/OR gate connections, the system designer can implement custom logic as convenient sum-of-products Boolean functions. System prototyping and design iterations can be performed quickly using these off-the-shelf products. A large variety of programming units and software makes design development and functional testing of PAL devices quick and easy. The Small PAL logic array has between 12 and 20 complementary inputs and up to 10 combinatorial outputs generated by a single programmable AND-gate array with fixed ORgate connections. The Small PAL family offers a variety of input/output combinations as shown in the Device Types table below. Security fuses can be programmed to prevent direct copying of proprietary logic patterns.

#### **Features**

- As fast as 25 ns maximum propagation delay
- User-programmable replacement for TTL logic
- Large variety of JEDEC-compatible programming equipment available
- Fully supported by National PLAN<sup>TM</sup> development software
- Security fuse prevents direct copying of logic patterns

## **Device Types**

Device Type	Dedicated Inputs	Combinatorial Outputs
PAL12L10	12	10
PAL14L8	14	8
PAL16L6	16	6
PAL18L4	18	4
PAL20L2	20	2
PAL20C1	20	1 Pair

## Speed/Power Versions

Series	Example	Comr	nercial	Military		
Genes			Icc	t <sub>PD</sub>	Icc	
Standard	PAL12L10	40 ns	100 mA	45 ns	100 mA	
Α	PAL12L10A	25 ns*	100 mA	30 ns*	100 mA	

\*Except PAL20C1A t<sub>PD</sub> = 30 ns Commercial, 35 ns Military.

## Block Diagram—PAL12L10



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#### Standard Series (PAL12L10, PAL14L8, PAL16L6, PAL18L4, PAL20L2, PAL20C1)

#### Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V <sub>CC</sub> ) (Note 2)	-0.5 to $+7.0$ V
Input Voltage (Notes 2 and 3)	-1.5 to +5.5V
Off-State Output Voltage (Note 2)	-1.5 to +5.5V
Input Current (Note 2)	-30.0 mA to +5.0 mA

Output Current (I<sub>OL</sub>) Storage Temperature Ambient Temperature with Power Applied Junction Temperature + 100 mA -65°C to + 150°C 24-Pin Small PAL Family

-65°C to +125°C

-65°C to +150°C

### **Recommended Operating Conditions**

Symbol	Parameter	Military				Units		
		Min	Nom	Max	Min	Nom	Max	
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	V
T <sub>A</sub>	Operating Free-Air Temperature	-55			0		75	°C
Τ <sub>C</sub>	Operating Case Temperature			125				°C

#### Electrical Characteristics Over Recommended Operating Conditions (Note 4)

Symbol	Parameter		Test Conditions		Min	Тур	Max	Units
VIL	Low Level Input Voltage (Note 5)						0.8	V
VIH	High Level Input Voltage (Note 5)			2			v	
V <sub>IC</sub>	Input Clamp Voltage	$V_{CC} = Min, I = -18 mA$				-0.8	-1.5	v
IIL	Low Level Input Current	$V_{\rm CC} = Max, V_1 = 0.4V$				-0.02	-0.25	mA
Iн	High Level Input Current	$V_{CC} = Max, V_1 = 2.4V$					25	μA
۹,	Maximum Input Current	$V_{CC} = Max, V_1 = 5.5V$					1	mA
VOL	Low Level Output Voltage	V <sub>CC</sub> = Min	I <sub>OL</sub> = 8 mA		0.3	0.5	V	
VOH	High Level Output Voltage	V <sub>CC</sub> = Min	$I_{OH} = -2 \text{ mA}$	MIL	2.4	3.0		v
			$I_{OH} = -3.2 \text{ mA}$	сом	2.4 5.0			v
los	Output Short-Circuit Current (Note 6)	$V_{CC} = 5V, V_O = 0V$			-30	-70	-130	mA
ICC	Supply Current	V <sub>CC</sub> = Max, O	utputs Open			60	100	mA

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. Proper operation is not guaranteed outside the specified recommended operating conditions.

Note 2: Some device pins may be raised above these limits during programming operations according to the applicable specification.

Note 3: It is recommended that precautions be taken to minimize electrostatic discharge when handling and testing this product. Pins 1 and 13 (DIP) are connected directly to the security fuses, and the security fuses may be damaged preventing subsequent programming and verification operations.

Note 4: All typical values are for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

Note 5: These are absolute voltages with respect to the ground pin on the device and include all overshoots due to system and/or tester noise. Do not attempt to test these values without suitable equipment.

Note 6: To avoid invalid readings in other parameter tests, it is preferable to conduct the I<sub>OS</sub> test last. To minimize internal heating, only one output should be shorted at a time with a maximum duration of 1.0 second each. Prolonged shorting of a high output may raise the chip temperature above normal and permanent damage may result.

**24-Pin Small PAL Family** 

# Standard Series (PAL12L10, PAL14L8, PAL16L6, PAL18L4, PAL20L2, PAL20C1) (Continued) Switching Characteristics Over Recommended Operating Conditions

Symbol	Parameter	ameter Test Conditions		Military		(	Commercia	ai	Units
			Min	Тур	Max	Min	Тур	Max	Unita
tPD	Input to Output	C <sub>L</sub> = 50 pF							
	L			25	45		25	40	ns

#### **Test Load**



## **Test Waveform**

#### **Propagation Delay**



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Notes:

 $V_{T} = 1.5V$ 

 $\mathbf{C}_{\mathrm{L}}$  includes probe and jig capacitance.

In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.

## Schematic of Inputs and Outputs



#### Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V <sub>CC</sub> ) (Note 2)	-0.5 to +7.0V
Input Voltage (Note 2)	-1.5 to +5.5V
Off-State Output Voltage (Note 2)	-1.5 to +5.5V
Input Current (Note 2)	-30.0 mA to +5.0 mA
Output Current (I <sub>OL</sub> )	+ 100 mA
Storage Temperature	-65°C to +150°C

**Recommended Operating Conditions** 

Ambient Temperature with Power Applied -65°C to +125°C **Junction Temperature** ESD Tolerance (Note 3)  $C_{ZAP} = 100 \text{ pF}$  $R_{ZAP} = 1500\Omega$ Test Method: Human Body Model Test Specification: NSC SOP-5-028

-65°C to +150°C 1500V

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Symbol	Parameter	Parameter Military		Commercial				
		Min	Nom	Max	Min	Nom	Max	Unita
V <sub>CC</sub>	Supply Voltage	4.5	5	5.5	4.75	5	5.25	٧
TA	Operating Free-Air Temperature	-55			0		75	°C
T <sub>C</sub>	Operating Case Temperature			125				°C

## Electrical Characteristics Over Recommended Operating Conditions (Note 4)

Symbol	Parameter		<b>Test Conditions</b>		Min	Тур	Max	Units
VIL	Low Level Input Voltage (Note 5)						0.8	v
VIH	High Level Input Voltage (Note 5)							v
VIC	Input Clamp Voltage	V <sub>CC</sub> = Min, I =	$V_{\rm CC} = Min, I = -18 \mathrm{mA}$				-1.5	V
IL	Low Level Input Current	$V_{CC} = Max$ , $V_1 = 0.4V$				-0.02	-0.25	mA
Iн	High Level Input Current	$V_{CC} = Max, V_I = 2.4V$					25	μΑ
l	Maximum Input Current	$V_{CC} = Max, V_1 = 5.5V$					100	μΑ
V <sub>OL</sub>	Low Level Output Voltage	V <sub>CC</sub> = Min	I <sub>OL</sub> = 8 mA		0.3	0.5	v	
V <sub>OH</sub>	High Level Output Voltage	V <sub>CC</sub> = Min	I <sub>OH</sub> = −2 mA	MIL	2.4	3.0		v
			$I_{OH} = -3.2  \text{mA}$	СОМ	- 2.4 5.0			ľ
los	Output Short-Circuit Current (Note 6)	$V_{\rm CC} = 5V, V_{\rm O} = 0V$			-30	- 70	-130	mA
łcc	Supply Current	V <sub>CC</sub> = Max, O	utputs Open			60	100	mA

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. Proper operation is not guaranteed outside the specified recommended operating conditions.

Note 2: Some device plas may be raised above these limits during programming operations according to the applicable specification,

Note 3: It is recommended that precautions be taken to minimize electrostatic discharge when handling and testing this product. Pins 1 and 13 (DiP) are connected directly to the security fuses, and although the input circuitry can withstand the specified ESD conditions, the security fuses may be damaged preventing subsequent programming and verification operations.

Note 4: All typical values are for  $V_{CC} = 5.0V$  and  $T_A = 25^{\circ}C$ .

Note 5: These are absolute voltages with respect to the ground pin on the device and include all overshoots due to system and/or tester noise. Do not attempt to test these values without suitable equipment.

Note 6: To avoid invalid readings in other parameter tests, it is preferable to conduct the IOS test last. To minimize internal heating, only one output should be shorted at a time with a maximum duration of 1.0 second each. Prolonged shorting of a high output may raise the chip temperature above normal and permanent damage may result.

24-Pin Small PAL Family

#### Series A (PAL12L10A, PAL14L8A, PAL16L6A, PAL18L4A, PAL20L2A, PAL20C1A) (Continued) Switching Characteristics Over Recommended Operating Conditions Commercial Military **Test Conditions** Units Symbol Parameter Min Max Тур Max Min Тур Input to Output $C_L = 50 \text{ pF}$ 12L10A, 14L8A, t<sub>PD</sub> 16L6A, 18L4A, 15 30 15 25 ns 20L2A 30 20C1A 35 ns

#### **Test Load**



## **Test Waveform**



#### Notes:

 $V_{T} = 1.5V$ 

 $\mathrm{C}_{\mathrm{L}}$  includes probe and jig capacitance.

In the examples above, the phase relationships between inputs and outputs have been chosen arbitrarily.

## Schematic of Inputs and Outputs





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24-Pin Small PAL Family



### **Functional Description**

The 24-pin Small PAL logic arrays consist of between 12 and 20 complementary input lines and either 16 or 20 product-term lines with a programmable fuse link at each intersection (up to 720 fuses). The family consists of six device types with different numbers of combinatorial outputs. The 24-pin Small PAL Family Block Diagrams show the number of product terms allocated to each output for each device. All product terms allocated to each output connect into an OR-gate to produce the sum-of-products output logic function.

An unprogrammed (intact) fuse establishes a connection between an input line (true or complement phase of an array input signal) and a product term; programming the fuse removes the connection. A product term is satisfied (logically true) while all of the input lines connected to it (via unprogrammed fuses) are in the high logic state. Therefore, if both the true and complement of at least one array input is left connected to a product line, that product term is always held in the low logic state (which is the state of all product terms in an unprogrammed device). Conversely, if all fuses on a product term were programmed, the product term and the resulting logic function would be held in the high state.

As with any TTL logic circuits, unused inputs to a PAL device should be connected to ground,  $V_{OL},\,V_{OH}$ , or resistively to  $V_{CC}.$  However, switching any input not connected to a product term or logic function has no effect on its output logic state.

Security Fuse

Security fuses are provided on all National PAL devices which, when programmed, inhibit any further programming

## **Ordering Information**



#### **Design Development Support**

A variety of software tools and programming hardware is available to support the development of designs using PAL products. Typical software packages accept Boolean logic equations to define desired functions. Most are available to run on personal computers and generate JEDEC-compatible "fuse maps". The industry-standard JEDEC format ensures that the resulting fuse-map files can be down-loaded into a variety of programming equipment. Many software packages and programming units support a wide variety of programmable logic products as well. The PLAN™ software package from National Semiconductor supports all programmable logic products available from National and is fully JEDEC-compatible. PLAN software also provides automatic device selection based on the designer's Boolean logic equations.

Detailed logic diagrams showing all JEDEC fuse-map addresses for the 24-pin Small PAL family are provided for direct map editing and diagnostic purposes. Contact your local National Semiconductor sales representative or distributor for a list of current software and programming support tools available for these devices. Contact the National Semiconductor Programmable Device Support Department if detailed specifications of PAL programming algorithms are needed.



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## Logic Diagram PAL12L10



24-Pin Small PAL Family



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## Logic Diagram PAL16L6







## Logic Diagram PAL20L2





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Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

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